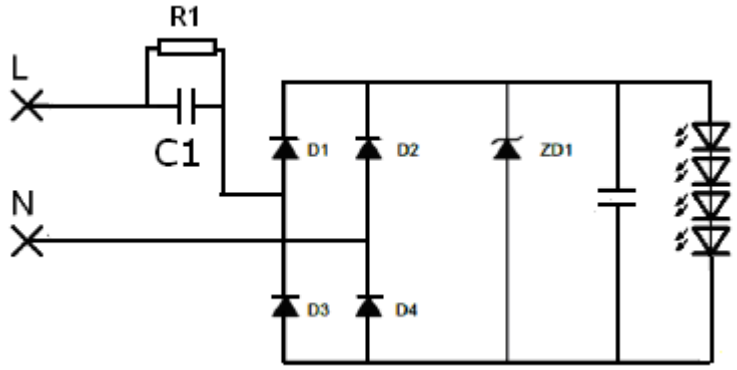
Messrs: 華信 From: HEC 禾伸堂

Date: 2015/03/11

1. Scope

This specification is applies to Multilayer Ceramic Chip Capacitor (MLCC) for **HCL series** .The capacitors are designed for LED lighting applications such as LED candle light. The HCL series is specially designed for LED R-C driver circuit connecting to AC city power of 110Vac and 220Vac for the LED lighting of Candle Lamp.

The reference schematic of R-C driver circuit is as the below and the HCL is only for C1 application.



The MLCC support for Lead-Free reflow soldering, and electrical characteristic and reliability are same as before. **(This product compliant with the RoHS.)**

2. Specification

ELECTRICAL CHARACTERISTICS :

Item	Specification
Dielectric/ Temperature Coefficient	X7R
Dimension	1812 , 2220
Capacitance Range	330nF ~ 1μF
Rated Voltage	450Vdc
Dissipation Factor	2.5% max. at 1KHz 25℃
Insulation Resistance	C≧0.01μF : More than 100 MΩ·μF
Capacitance Tolerance	± 10% , ± 20%, (+0 / +20 % on request)
Operation Temperature	-55℃ ~ +125℃

Parts Number

Part No.	Capacitance (μF)	Test Frequency	Rated Voltage	Tolerance
HCL1812X334K451T	0.33	1KHz±10%@1.0±0.2Vrms	450 Vdc	± 10 %
HCL1812X474K451T	0.47	1KHz±10%@1.0±0.2Vrms	450 Vdc	± 10 %

Other Capacitance on Request!

3. Operation Temperature Range

Class	Characteristic	Temperature Range	Reference Temp.
Ⅱ	X7R	-55℃ ~ +125℃	25℃

4. Storage Condition

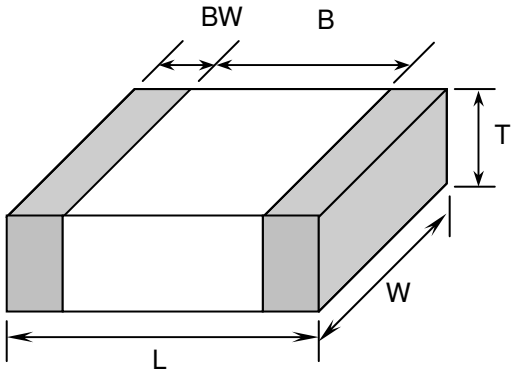
Storage Temperature：5 to 40℃

Relative Humidity：20 to 70 %

Storage Time：12 months max.

5. Dimensions

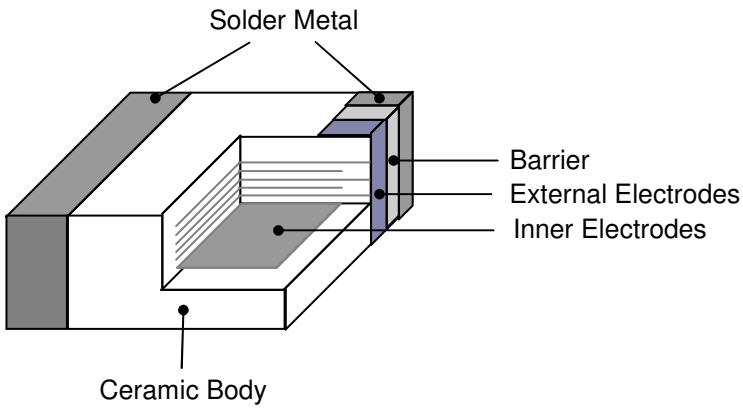
5.1 Configuration and Dimension：



Unit:mm

TYPE	Capacitance Code	L	W	T	B (min)	BW (min)
1812	334	4.60± 0.30	3.20± 0.30	2.0±0.2	2.50	0.30
1812	474	4.60± 0.30	3.20± 0.30	2.4±0.2	2.50	0.30

5.2 Termination Type：

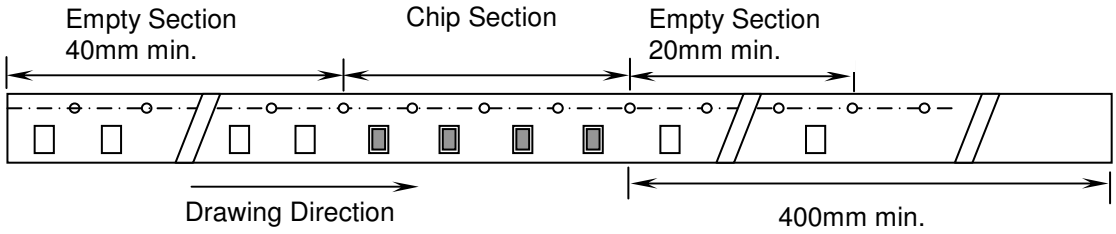


6. Packing

6.1 Bulk Packing

According to customer request.

6.2 Chip Capacitors Tape Packing



6.3 Material And Quantity

Tape Material	1812		2220	
	T≦2.20mm	T＞2.20mm	T≦2.20mm	T＞2.20mm
Paper	NA	NA	NA	NA
Plastic	1000 pcs/Reel	700 pcs/Reel	1000 pcs/Reel	700pcs/Reel

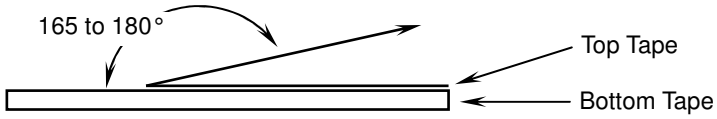
NA：Not Available

6.4 Cover Tape Reel Off Force

8.4.1 Peel-Off Force

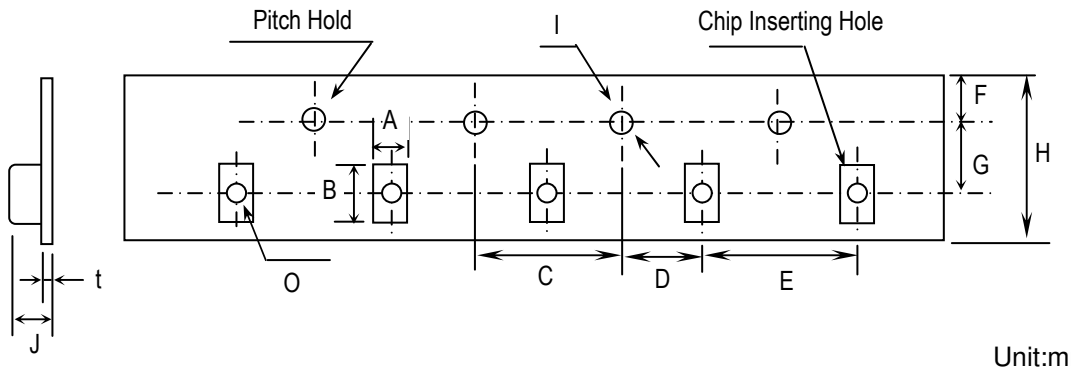
5 g·f ≦ Peel-Off Force ≦ 70 g·f

8.4.2 Measure Method



Unit:mm

6.5 Plastic Tape

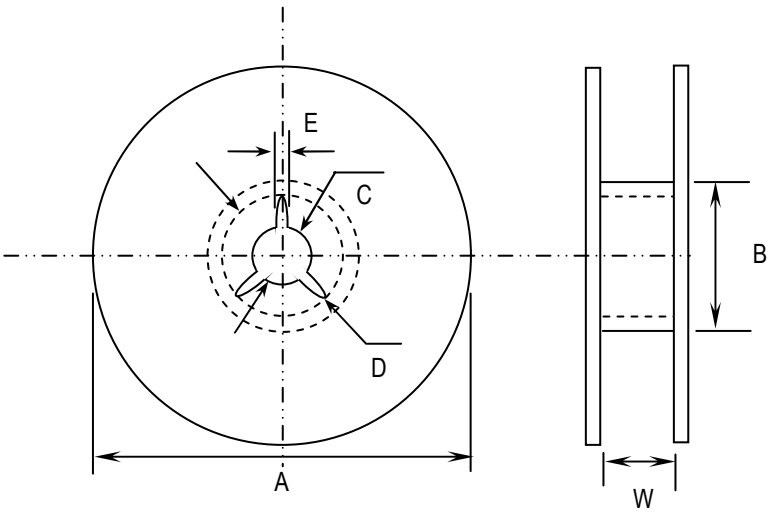


Unit:mm

Type	A	B	C	D	E	F
1812	3.6±0.2	4.9±0.2	4.0± 0.1	2.0± 0.05	4.0± 0.1	1.75± 0.1
2220	5.4±0.2	6.1±0.2			8.0± 0.1	

6.6 Reel Dimensions

Reel Material：Polystyrene



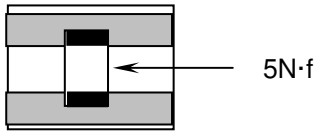
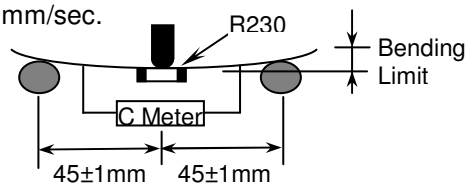
Unit:mm

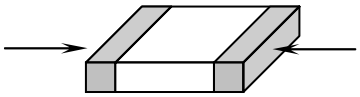
Type	A	B	C	D	E	W
1812	φ 178±0.2	φ 60±0.2	φ 13± 0.5	φ 21± 0.8	2.0±0.5	13±0.3
2220						

7. Performance

<table>
<tr><th>No.</th><th colspan="2">Item</th><th colspan="3">Specification</th><th>Test Condition</th></tr>
<tr><td>1</td><td colspan="2">Visual</td><td colspan="3">No abnormal exterior appearance</td><td>Visual inspection</td></tr>
<tr><td>2</td><td colspan="2">Dimension</td><td colspan="3">See Page 2</td><td>Visual inspection</td></tr>
<tr><td>3</td><td colspan="2">Insulation Resistance</td><td colspan="3">C≧0.01μF : More than 100 MΩ·μF</td><td>V≦500V, Rated Voltage

Charge Time：60sec.
Is applied less than 50mA current.</td></tr>
<tr><td rowspan="3">4</td><td rowspan="3">Capacitance</td><td>Class Ⅰ NPO/SL</td><td colspan="3">Within The Specified Tolerance</td><td rowspan="3">Class Ⅰ：
NPO/SL
<table><tr><td>Capacitance</td><td>Frequency</td><td>Voltage</td></tr><tr><td>C≦100pF</td><td>1MHz±10%</td><td rowspan="2">1.0±0.2Vrms</td></tr><tr><td>C＞100pF</td><td>1KHz±10%</td></tr></table>Class Ⅱ：
<table><tr><td colspan="2">Frequency</td><td>Voltage</td></tr><tr><td>X7R</td><td>1KHz±10%</td><td>1.0±0.2Vrms</td></tr><tr><td>Z5U/Y5U</td><td>1KHz±10%</td><td>1.0±0.2Vrms</td></tr></table>Perform a heat temperature at 150±5℃ for 30min. then place room temp. for 24±2hr.</td></tr>
<tr><td>Class Ⅱ</td><td colspan="3">Within The Specified Tolerance</td></tr>
<tr><td rowspan="3">5</td><td>Q</td><td>Class Ⅰ NPO/SL</td><td colspan="3">More Than 30pF : Q ≧1000
30pF & Below: Q≧400＋20C
(C : Capacitance , pF)</td></tr>
<tr><td rowspan="2">Tan δ</td><td rowspan="2">Class Ⅱ</td><td>Char.</td><td colspan="2">Maximum</td></tr>
<tr><td>X7R</td><td colspan="2">2.5%</td></tr>
<tr><td>Z5U/Y5U</td><td colspan="2">4.0%</td></tr>
<tr><td>6</td><td colspan="2">Withstanding Voltage</td><td colspan="3">No dielectric breakdown or mechanical breakdown</td><td>V＜500V　: 120% Rated Voltage
for 1~5 sec. Current is limited to less than 50mA.

※ Withstanding voltage testing requires immersion of the element in a isolation fluid prevent arcing on the chip surface, at voltage over 1000Vdc.</td></tr>
<tr><td rowspan="6">7</td><td rowspan="6">Temperature Capacitance Coefficient</td><td rowspan="3">Class Ⅰ</td><td>Char.</td><td>Temp. Range</td><td>Cap. Change(%)</td><td rowspan="6">Class Ⅰ：
[C2-C1/C1(T2-T1)] × 100%
Class Ⅱ：
(C2-C1)/C1 × 100%
T1: Standard temperature (25℃)
T2: Test temperature
C1:Capacitance at standard temperature(25℃)
C2: Capacitance at test temperature (T2)</td></tr>
<tr><td>NPO</td><td>-55℃~+125℃</td><td>± 30 ppm/℃</td></tr>
<tr><td>SL</td><td>-30℃~+85℃</td><td>+350~-1000ppm</td></tr>
<tr><td rowspan="3">Class Ⅱ</td><td>Char.</td><td>Temp. Range</td><td>Cap. Change(%)</td></tr>
<tr><td>X7R</td><td>-55℃~+125℃</td><td>± 15%</td></tr>
<tr><td>Y5U</td><td>-30℃~+85℃</td><td>+22% ~-56%</td></tr>
<tr><td>Z5U</td><td>+10℃~+85℃</td><td>+22% ~-56%</td></tr>
<tr><td>8</td><td colspan="2">Adhesive Strength of Termination</td><td colspan="3">No indication of peeling shall occur on the terminal electrode.</td><td>A 5N·f (≒0.5Kg·f) pull force shall be applied for 10± 1 second.
 
</td></tr>
<tr><td rowspan="6">9</td><td rowspan="6">Resistance to Flexure of Substrate</td><td>Appear-ance</td><td colspan="3">No mechanical damage shall be occur.</td><td rowspan="6">Bending shall be applied to the 1.0 mm with 1.0 mm/sec.
 
</td></tr>
<tr><td>C-Meter</td><td colspan="3">Capacitance Change</td></tr>
<tr><td colspan="2">Char.</td><td>Cap. Change</td></tr>
<tr><td colspan="2">NPO</td><td>≦ ± 5.0%</td></tr>
<tr><td colspan="2">SL</td><td>≦ ± 5.0%</td></tr>
<tr><td colspan="2">X7R</td><td>≦ ± 12.5%</td></tr>
<tr><td colspan="2">Y5U/Z5U</td><td>≦ ± 30.0%</td></tr>
</table>

<table>
<tr><th>No.</th><th colspan="2">Item</th><th>Specification</th><th>Test Condition</th></tr>
<tr><td>10</td><td colspan="2">Solderability</td><td>More than 90% of the terminal surface is to be soldered newly, so metal part does not come out or dissolve .
  </td><td>Solder Temperature : 245± 5℃
Dip Time : 5 ± 0.5 sec.
Immersing Speed : 25±10% mm/s
Solder : H63A
Flux :Rosin
Preheat : At 80~120 ℃ for 10~30sec.</td></tr>
<tr><td rowspan="7">11</td><td rowspan="7">Resistance To Soldering Heat</td><td>Appear-ance</td><td>No mechanical damage shall occur.</td><td rowspan="7">Class Ⅱ capacitor shall be set for 48±4 hours at room temperature after one hour heat treatment at 150 +0/-10℃ before initial measure.
Preheat : At 150± 10℃ For 60~120sec.
Dip : Solder Temperature of 260± 5℃
Dip Time : 10 ± 1sec.
Immersing Speed : 25±10% mm/s
Solder : H63A
Flux :Rosin

Measure at room temperature after cooling for
Class Ⅰ : 24 ± 2 Hours
Class Ⅱ : 48 ± 4 Hours</td></tr>
<tr><td>Capacit-ance</td><td><table><tr><td colspan="2">Characteristic</td><td>Cap. Change</td></tr><tr><td colspan="2">Class Ⅰ (NPO/SL)</td><td>Within ± 2.5% or ±0.25pFwhichever is larger of initial value</td></tr><tr><td rowspan="2">Class Ⅱ</td><td>X7R</td><td>Within ± 10%</td></tr><tr><td>Z5U/Y5U</td><td>Within ± 20%</td></tr></table></td></tr>
<tr><td>Q
Class Ⅰ</td><td>To satisfy the specified initial value</td></tr>
<tr><td>Tan δ
Class Ⅱ</td><td>To satisfy the specified initial value</td></tr>
<tr><td>Insulation Resistance</td><td>To satisfy the specified initial value</td></tr>
<tr><td>Withstand Voltage</td><td>To satisfy the specified initial value</td></tr>
<tr><td rowspan="6">12</td><td rowspan="6">Tempera-. ture Cycle</td><td>Appear-ance</td><td>No mechanical damage shall occur</td><td rowspan="6">Class Ⅱ capacitor shall be set for 48± 4 hours at room temperature after one hour heat treatment at 150 +0/-10 ℃ before initial measure.

Capacitor shall be subjected to five cycles of the temperature cycle as following:<table><tr><th>Step</th><th>Temp.(℃)</th><th>Time(min)</th></tr><tr><td>1</td><td>Min Rated Temp. +0/-3</td><td>30</td></tr><tr><td>2</td><td>25</td><td>3</td></tr><tr><td>3</td><td>Max Rated Temp. +3/-0</td><td>30</td></tr><tr><td>4</td><td>25</td><td>3</td></tr></table>Measure at room temperature after cooling for
Class Ⅰ :24 ± 2 Hrs
Class Ⅱ :48 ± 4 Hrs
Solder the capacitor on P.C. board shown in Fig 2. before testing.</td></tr>
<tr><td>Capacit-ance</td><td><table><tr><td colspan="2">Characteristic</td><td>Cap. Change</td></tr><tr><td colspan="2">Class Ⅰ (NPO/SL)</td><td>Within ± 2.5% or ±0.25pFwhichever is larger of initial value</td></tr><tr><td rowspan="2">Class Ⅱ</td><td>X7R</td><td>Within ± 7.5%</td></tr><tr><td>Z5U/Y5U</td><td>Within ± 20%</td></tr></table></td></tr>
<tr><td>Q
Class Ⅰ</td><td>To satisfy the specified initial value</td></tr>
<tr><td>Tan δ
Class Ⅱ</td><td>To satisfy the specified initial value</td></tr>
<tr><td>Insulation Resistance</td><td>To satisfy the specified initial value</td></tr>
<tr><td rowspan="6">13</td><td rowspan="6">Humidity</td><td>Appear-ance</td><td>No mechanical damage shall occur</td><td rowspan="6">Class Ⅱ capacitor shall be set for 48± 4 hours at room temperature after one hour heat treatment at 150+0/-10 ℃ before initial measure.
Temperature : 40± 2℃
Relative Humidity : 90 ~ 95%RH
Test Time : 500 +12/−0Hr

Measure at room temperature after cooling for
Class Ⅰ : 24 ± 2Hrs
Class Ⅱ : 48 ± 4Hrs

Solder the capacitor on P.C. board shown in Fig 2. before testing.</td></tr>
<tr><td>Capacit-ance</td><td><table><tr><td colspan="2">Characteristic</td><td>Cap. Change</td></tr><tr><td colspan="2">Class Ⅰ (NPO/SL)</td><td>Within ± 5.0% or ±0.5pF whichever is larger of initial value</td></tr><tr><td rowspan="2">Class Ⅱ</td><td>X7R</td><td>Within ± 15%</td></tr><tr><td>Z5U/Y5U</td><td>Within ± 30%</td></tr></table></td></tr>
<tr><td>Q
Class Ⅰ</td><td>More Than 30pF : Q ≧350
30pF & Below: Q ≧275 +2.5×C</td></tr>
<tr><td>Tan δ
Class Ⅱ</td><td><table><tr><td>Char.</td><td>Maximum</td></tr><tr><td>X7R</td><td>5.0%</td></tr><tr><td>Z5U/Y5U</td><td>5.0%</td></tr></table></td></tr>
<tr><td>Insulation Resistance</td><td>10 MΩ·μF</td></tr>
</table>

Precautionary Notes:

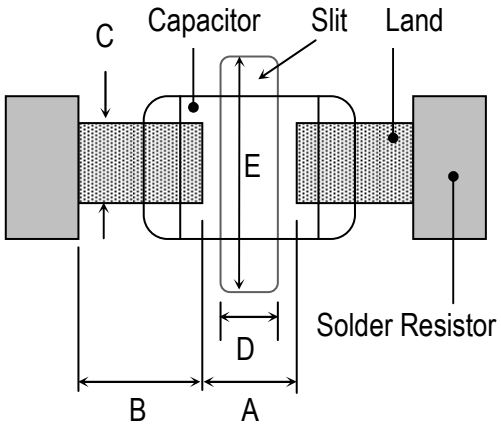
1. Storage

Store the capacitors where the temperature and relative humidity don't exceed 40℃ and 70%RH. We recommend that the capacitors be used within 12 months from the date of manufacturing. Store the products in the original package and do not open the outer wrapped, polyethylene bag, till just before usage. If it is open, seal it as soon as possible or keep it in a desiccant with a desiccation agent.

2. Construction of Board Pattern

Improper circuit layout and pad/land size may cause excessive or not enough solder amount on the PC board. Not enough solder may create weak joint, and excessive solder may increase the potential of mechanical or thermal cracks on the ceramic capacitor. Therefore we recommend the land size to be as shown in the following table:

2.1 Size and recommend land dimensions for reflow soldering .



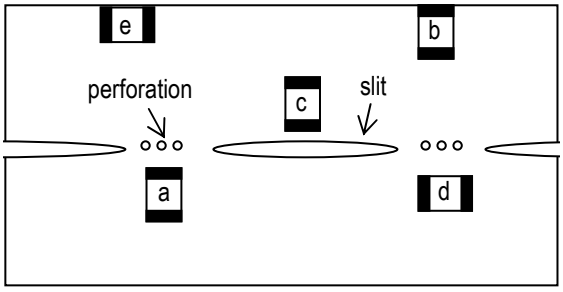
EIA Code	Chip (mm)		Land (mm)				
	L	W	A	B	C	D	E
1812	4.60	3.20	2.8~3.4	1.8~2.0	2.3~3.0	1.0~2.8	4.8~5.3
2220	5.70	5.00	4.0~4.6	2.0~2.2	3.5~4.8	1.0~4.0	6.6~7.1

2.2 Mechanical strength varies according to location of chip capacitors on the P.C. board.

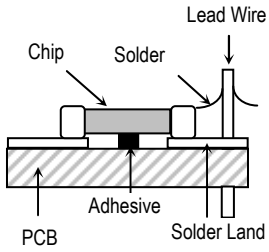
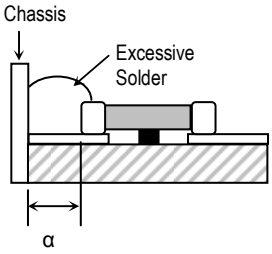
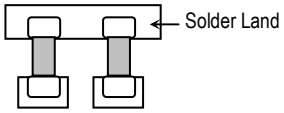
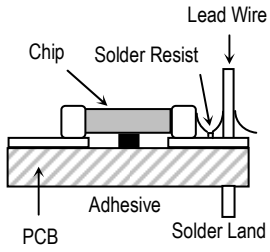
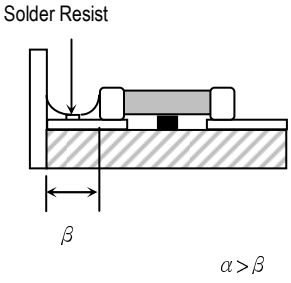
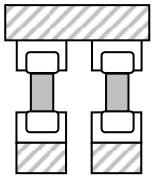
Design layout of components on the PC board such a way to minimize the stress imposed on the components, upon flexure of the boards in depanelization or other processes.

Component layout close to the edge of the board or the "depanelization line" is not recommended.

Susceptibility to stress is in the order of: a>b>c and d>e

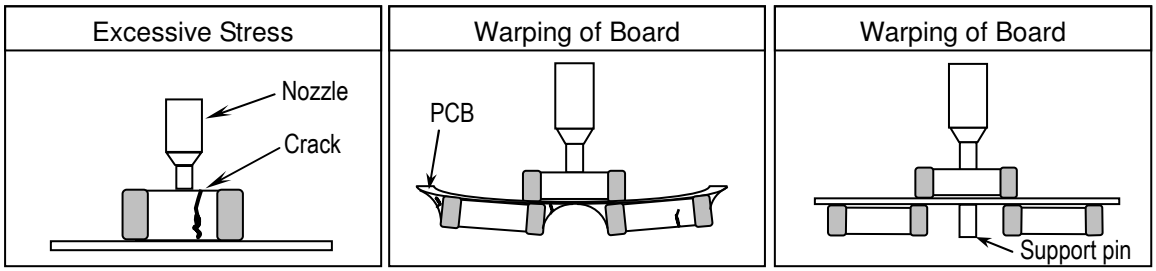


2.3 Layout Recommendation

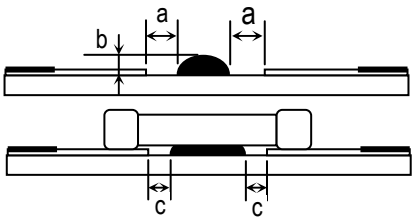
Example	Use of Common Solder Land	Solder With Chassis	Use of Common Solder Land With Other SMD
Need to Avoid			
Recommendation			

3. Mounting

3.1 Sometimes crack is caused by the impact load due to suction nozzle in pick and place operation.
In pick and place operation, if the low dead point is too low, excessive stress is applied to component. This may cause cracks in the ceramic capacitor, therefore it is required to move low dead point of a suction nozzle to the higher level to minimize the board warp age and stress on the components. Nozzle pressure is typically adjusted to 1N to 3N (static load) during the pick and place operation.



3.2 Amount of Adhesive



Example : 0805 & 1206

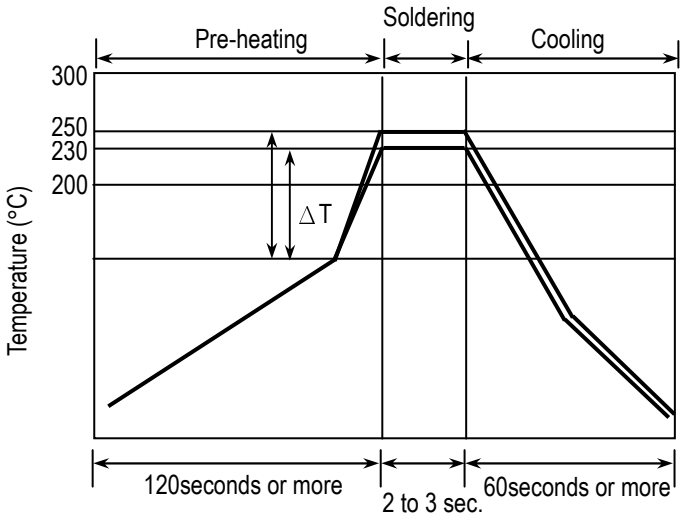
a	0.2mm min.
b	70 ~ 100 μm
c	Do not touch the solder land

4. Soldering

4.1. Wave Soldering

Most of components are wave soldered with solder at 230 to 250℃. Adequate care must be taken to prevent the potential of thermal cracks on the ceramic capacitors. Refer to the soldering methods below for optimum soldering benefits.

Recommend flow soldering temperature Profile



Soldering Method	Change in Temp.(℃)
1206 and Under	ΔT ≤ 100~130 max.

To optimize the result of soldering, proper preheating is essential:

1) Preheat temperature is too low
   a. Flux flows to easily
   b. Possibility of thermal cracks
2) Preheat temperature is too high
   a. Flux deteriorates even when oxide film is removed
   b. Causes warping of circuit board
   c. Loss of reliability in chip and other components

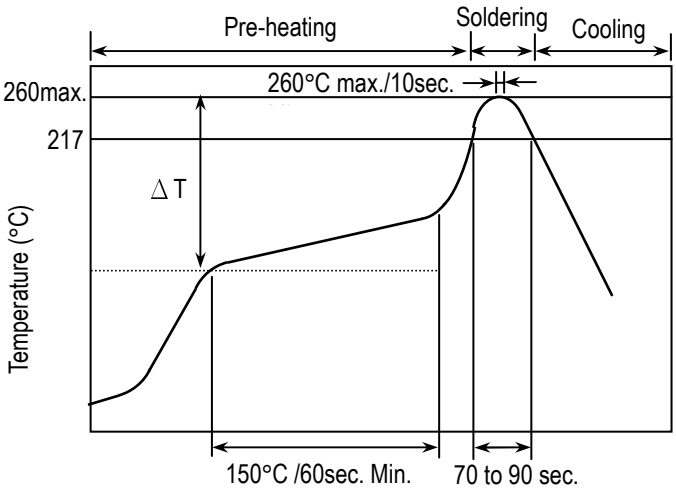
Cooling Condition:

Natural cooling using air is recommended. If the chips are dipped into a solvent for cleaning, the temperature difference (ΔT) between the solvent and the chips must be less than 100℃.

4.2 Reflow Soldering

Preheat and gradual increase in temperature to the reflow temperature is recommended to decrease the potential of thermal crack on the components. The recommended heating rate depends on the size of component, however it should not exceed 3℃/Sec.

Recommend reflow profile for Lead-Free soldering temperature Profile (MIL-STD-202G #210F)

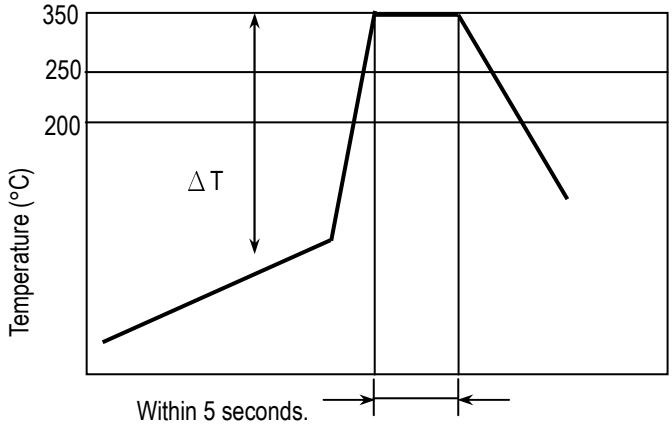


※ The cycles of soldering : Twice (max.)

Soldering Method	Change in Temp.(℃)
1206 and Under	ΔT ≦ 190 ℃
1210 and Over	ΔT ≦ 130 ℃

4.3 Hand Soldering

Sudden temperature change in components, results in a temperature gradient recommended in the following table, and therefore may cause internal thermal cracks in the components. In general a hand soldering method is not recommended unless proper preheating and handling practices have been taken. Care must also be taken not to touch the ceramic body of the capacitor with the tip of solder Iron.



Soldering Method	Change in Temp.(℃)
1206 and Under	ΔT ≦ 190 ℃
1210 and Over	ΔT ≦ 130 ℃

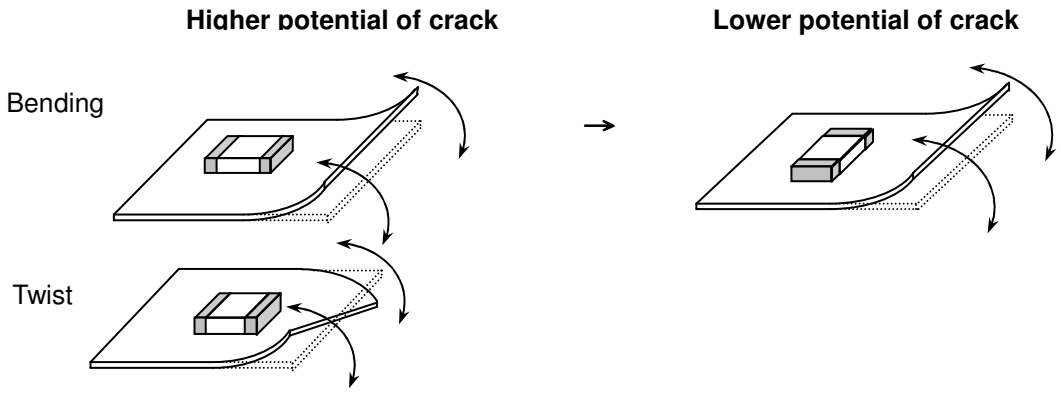
How to Solder Repair by Solder Iron

1) Selection of the soldering iron tip
The required temperature of solder iron for any type of repair depends on the type of the tip, the substrate material, and the solder land size.

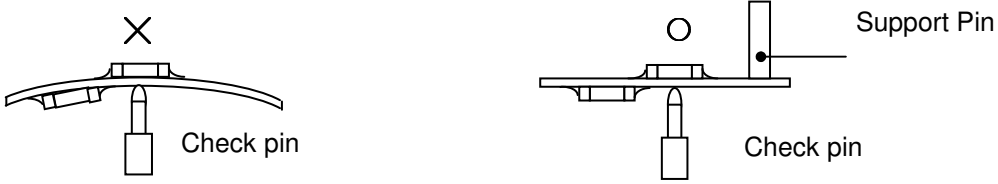
2) recommended solder iron condition
a.) Preheat the substrate to (60℃ to 120℃) on a hot plate. Note that due to the heat loss, the actual setting of the hot plate may have to be higher. (For example 100℃ to 150℃)
b.) Soldering iron power shall not exceed 30 W.
c.) Soldering iron tip diameter shall not exceed 3mm.
d.) Temperature of iron tip shall not exceed 350℃., and the process should be finished within 5 seconds. (refer to MIL-STD-202G)
f.) Do not touch the ceramic body with the tip of solder iron. Direct contact of the soldering iron tip to ceramic body may cause thermal cracks.
g.) After soldering operation, let the products cool down gradually in the room temperature.

5. Handling after chip mounted

5.1 Proper handling is recommended, since excessive bending and twist of the board, depends on the orientation of the chip on the board, may induce mechanical stress and cause internal crack in the capacitor.



5.2 There is a potential of crack if board is warped due to excessive load by check pin

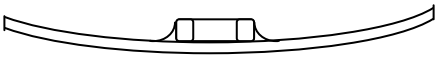


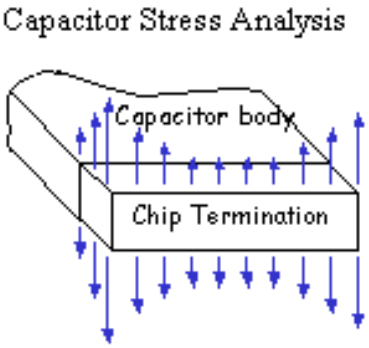
5.3 Mechanical stress due to warping and torsion.

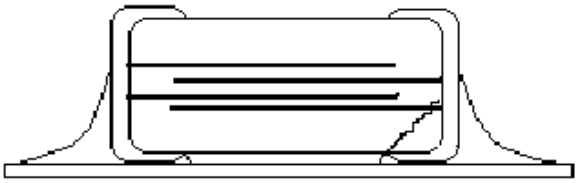
(a) Crack occurrence ratio will be increased by manual separation.

(b) Crack occurrence ratio will be increased by tensile force , rather than compressive force.

╳ :Tensile Stress ○ :Compressive Stress

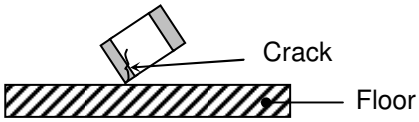




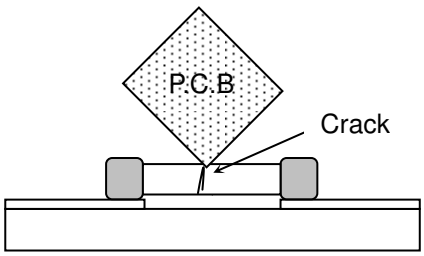


6. Handling of Loose Chip Capacitor

6.1 If dropped the chip capacitor may crack.



6.2 In piling and stacking of the P.C. boards after mounting for storage or handling, the corner of the P.C. board may hit the chip capacitor mounted on another board to cause crack.



7. Safekeeping condition and period

For safekeeping of the products, we recommend to keep the storage temperature between +5 to +40℃ and under humidity of 20 to 75% RH. The shelf life of capacitors is 12 months.